

# GP1S28

## Subminiature Photointerrupter

## ■ Features

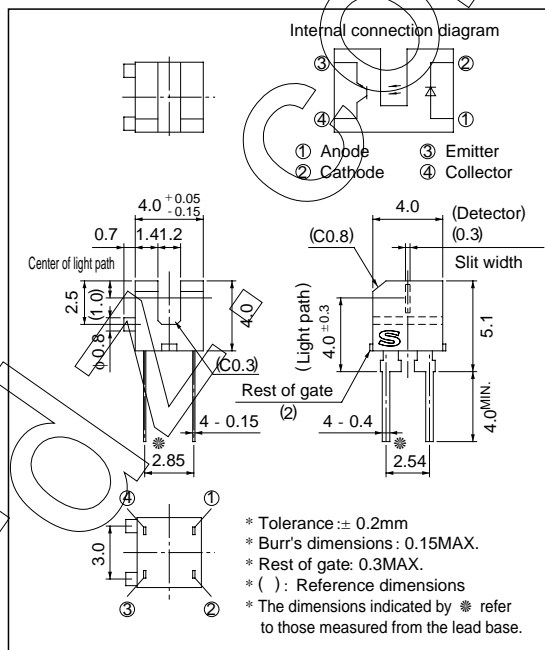
1. Ultra-compact
2. PWB mounting type package
3. High sensing accuracy (Slit width 0.3mm )
4. With mounting boss

## ■ Applications

1. Cameras
2. Floppy disk drives

## ■ Outline Dimensions

~~(Unit : mm )~~

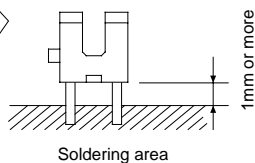


### ■ Absolute Maximum Ratings

(Ta= 25°C)

Parameter		Symbol	Rating	Unit
Input	Forward current	$I_F$	50	mA
	Reverse voltage	$V_R$	6	V
	Power dissipation	$P$	75	mW
Output	Collector-emitter voltage	$V_{CEO}$	35	V
	Emitter-collector voltage	$V_{ECO}$	6	V
	Collector current	$I_C$	20	mA
	Collector power dissipation	$P_C$	75	mW
	Total power dissipation	$P_{tot}$	100	mW
Operating temperature		$T_{opr}$	- 25 to + 85	°C
Storage temperature		$T_{stg}$	- 40 to + 100	°C
*!Soldering temperature		$T_{sol}$	260	°C

\*1 For 5 seconds



■ Electro-optical Characteristics

( $T_a = 25^{\circ}\text{C}$ )

Parameter			Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Input	Forward voltage		$V_F$	$I_F = 20\text{mA}$	-	1.2	1.4	V
	Reverse current		$I_R$	$V_R = 3\text{V}$	-	-	10	$\mu\text{A}$
Output	Collector dark current		$I_{\text{CEO}}$	$V_{\text{CE}} = 20\text{V}$	-	-	$1 \times 10^{-7}$	A
Transfer characteristics	Collector Current		$I_C$	$V_{\text{CE}} = 5\text{V}, I_F = 5\text{mA}$	100	-	1300	$\mu\text{A}$
	Collector-emitter saturation voltage		$V_{\text{CE(sat)}}$	$I_F = 10\text{mA}, I_C = 50 \mu\text{A}$	-	-	0.4	V
	Response time	Rise time	$t_r$	$V_{\text{CE}} = 5\text{V}, R_L = 1\text{k}\Omega$	-	50	150	$\mu\text{s}$
		Fall time	$t_f$	$I_C = 100 \mu\text{A}$	-	50	150	$\mu\text{s}$

Fig. 1 Forward Current vs. Ambient Temperature

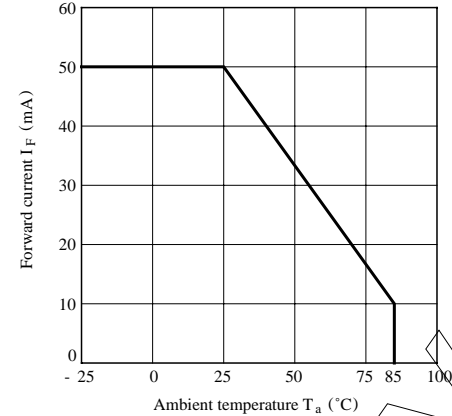


Fig. 2 Power Dissipation vs. Ambient Temperature

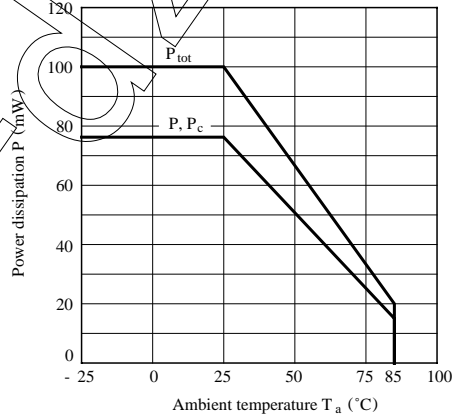


Fig. 3 Forward Current vs. Forward Voltage

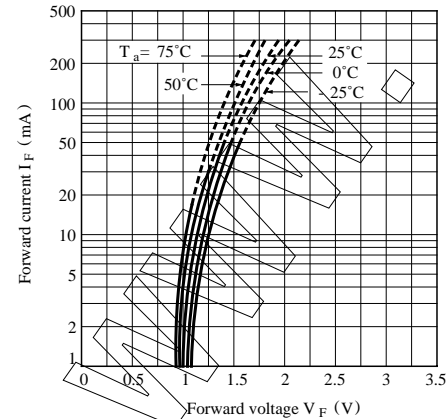
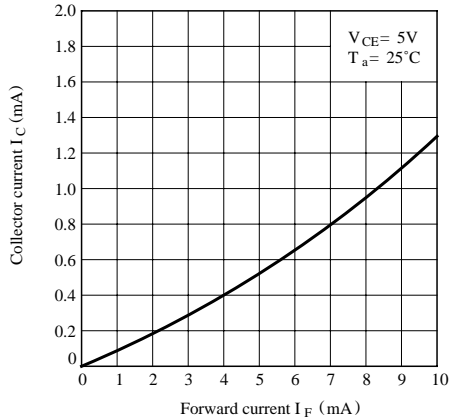
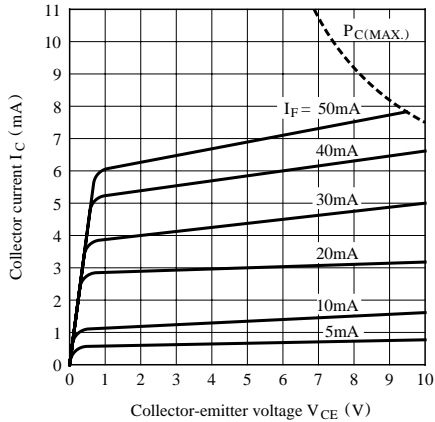


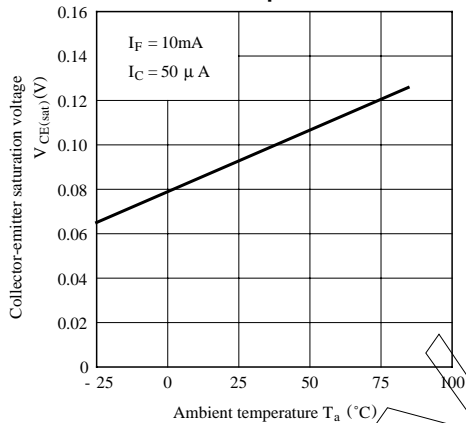
Fig. 4 Collector Current vs. Forward Current



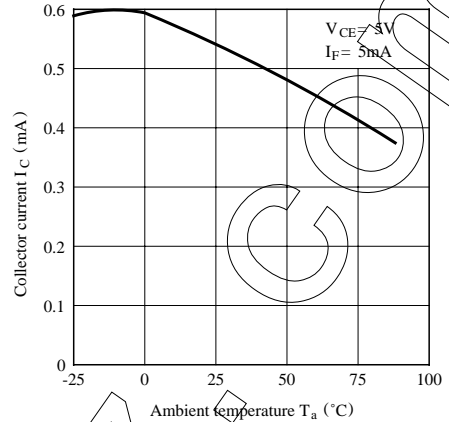
**Fig. 5 Collector Current vs. Collector-emitter Voltage**



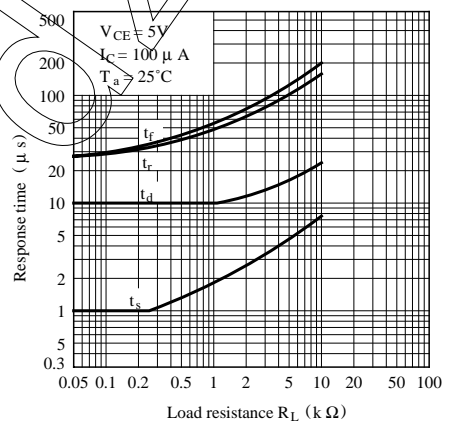
**Fig. 7 Collector-emitter Saturation Voltage vs. Ambient Temperature**



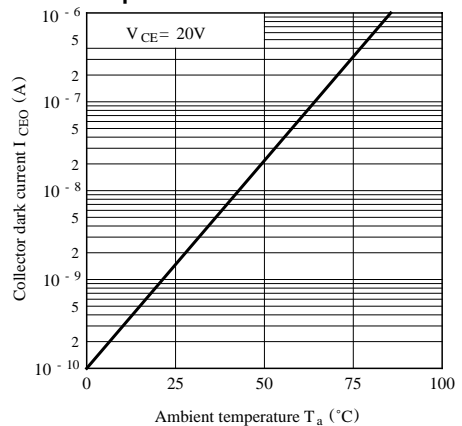
**Fig. 6 Collector Current vs. Ambient Temperature**



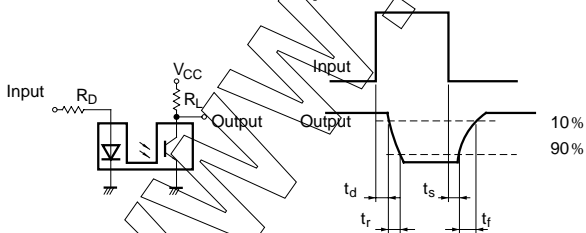
**Fig. 8 Response Time vs. Load Resistance**

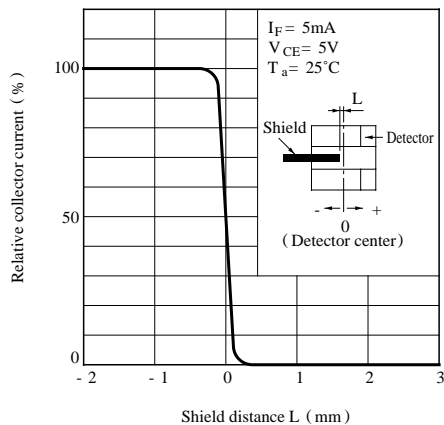
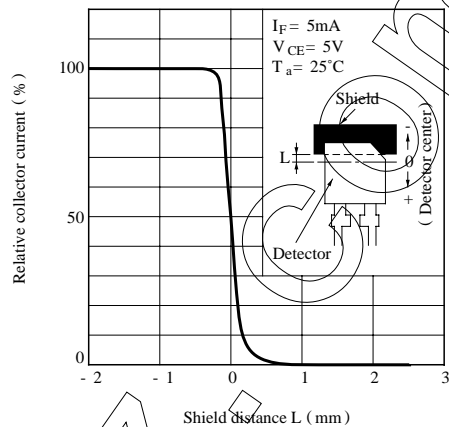


**Fig. 9 Collector Dark Current vs. Ambient Temperature**



**Test Circuit for Response Time**



**Fig.10 Relative Collector Current vs. Shield Distance (1)****Fig.11 Relative Collector Current vs. Shield Distance (2)**

- Please refer to the chapter “Precautions for Use”.

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    - Alarm equipment
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